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ON Semiconductor®

FDS6986AS

Dual Notebook Power Supply N-Channel PowerTrench® SyncFET[™] General Description

The FDS6986AS is designed to replace two single SO-8 MOSFETs and Schottky diode in synchronous DC:DC power supplies that provide various peripheral voltages for notebook computers and other battery powered electronic devices. FDS6986AS contains two unique 30V, N-channel, logic level, PowerTrench MOSFETs designed to maximize power conversion efficiency.

The high-side switch (Q1) is designed with specific emphasis on reducing switching losses while the low-side switch (Q2) is optimized to reduce conduction losses. Q2 also includes an integrated Schottky diode using ON Semiconductor's monolithic SyncFET technology.

Features

 Q2: Optimized to minimize conduction losses Includes SyncFET Schottky body diode

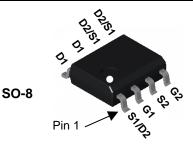
7.9A, 30V
$$R_{DS(on)} = 20 \text{ m}\Omega @ V_{GS} = 10V$$

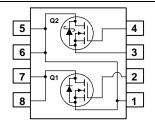
$$R_{DS(on)} = 28 \text{ m}\Omega @ V_{GS} = 4.5V$$

 Q1: Optimized for low switching losses Low gate charge (10 nC typical)

6.5A, 30V
$$R_{DS(on)} = 29 \text{ m}\Omega @ V_{GS} = 10V$$

$$R_{DS(on)} = 38 \text{ m}\Omega @ V_{GS} = 4.5V$$





Absolute Maximum Ratings T_a = 25°C unless otherwise noted

Symbol Parameter Q2 Q1 V _{DSS} Drain-Source Voltage 30 30 V _{GSS} Gate-Source Voltage ±20 ±16 I _D Drain Current - Continuous (Note 1a) - Pulsed 7.9 6.5 - Pulsed 30 20 P _D Power Dissipation for Dual Operation (Note 1a) (Note 1a) (Note 1b) (Note 1b) (Note 1b) (Note 1b) (Note 1c) 1.6 T _L T _{STG} Operating and Storage Junction Temperature Range -55 to +150						
VGSS Gate-Source Voltage ±20 ±16 ID Drain Current - Continuous - Pulsed (Note 1a) 7.9 6.5 - Pulsed 30 20 Power Dissipation for Dual Operation Power Dissipation for Single Operation (Note 1a) (Note 1b) (Note 1b) (Note 1b) 1.6 (Note 1b) (Note 1c) 0.9	Symbol			Q2	Q1	Units
ID Drain Current - Continuous - Pulsed (Note 1a) 7.9 6.5 PD Power Dissipation for Dual Operation Power Dissipation for Single Operation (Note 1a) (Note 1b) (Note 1b) (Note 1b) (Note 1c) 1.6	V _{DSS}			30	30	V
- Pulsed 30 20 PD Power Dissipation for Dual Operation 2 Power Dissipation for Single Operation (Note 1a) 1.6 (Note 1b) 1 (Note 1c) 0.9	V _{GSS}	Gate-Source Voltage		±20	±16	V
Power Dissipation for Dual Operation 2 Power Dissipation for Single Operation (Note 1a) 1.6 (Note 1b) 1 (Note 1c) 0.9	I _D	Drain Current - Continuous	(Note 1a)	7.9	6.5	Α
Power Dissipation for Single Operation		- Pulsed		30	20	
(Note 1b) 1 (Note 1c) 0.9	P _D	Power Dissipation for Dual Operation		2		W
(Note 1c) 0.9		Power Dissipation for Single Operation	(Note 1a)	1.	6	
, , , , , , , , , , , , , , , , , , ,			(Note 1b)	1		
T. T. Operating and Storage Junction Temporature Pange 55 to 1150			(Note 1c)	0.	9	
13, 18TG Operating and Storage surretion reinperature Kange =33 to +130	T _J , T _{STG}	Operating and Storage Junction Temperature Range		−55 to	+150	°C

Thermal Characteristics

$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient	(Note 1a)	78	°C/W
R _{eJC}	Thermal Resistance, Junction-to-Case	(Note 1)	40	°C/W

Package Marking and Ordering Information

Device Marking	Device	Reel Size	Tape width	Quantity
FDS6986AS	FDS6986AS	13"	12mm	2500 units
FDS6986AS	FDS6986AS-NL (Note 4)	13"	12mm	2500 units

Symbol	Parameter	Test Conditions	Type	Min	Тур	Max	Units
Off Cha	racteristics						
BV _{DSS}	Drain-Source Breakdown Voltage	$V_{GS} = 0 \text{ V}, I_D = 1 \text{ mA}$ $V_{GS} = 0 \text{ V}, I_D = 250 \text{ uA}$	Q2 Q1	30 30			V
ΔBVDSS	Breakdown Voltage	I _D = 1 mA, Referenced to 25°C	Q2		31		mV/°C
ΔT_J	Temperature Coefficient	$I_D = 250 \mu A$, Referenced to 25°C	Q1		23		
I _{DSS}	Zero Gate Voltage Drain Current	$V_{DS} = 24 \text{ V}, V_{GS} = 0 \text{ V}$	Q2 Q1			500 1	μА
I _{GSS}	Gate-Body Leakage	$V_{GS} = \pm 20 \text{ V}, V_{DS} = 0 \text{ V}$ $V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$	Q2 Q1			±100	nA
On Cha	racteristics (Note 2)	, 50					
V _{GS(th)}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 1$ mA	Q2	1	1.7	3	V
GG(iii)	g	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	Q1	1	1.9	3	
$\Delta V_{GS(th)}$	Gate Threshold Voltage	I _D = 1 mA, Referenced to 25°C	Q2		-3.2		mV/°C
ΔT_{J}	Temperature Coefficient	I _D = 250 uA, Referenced to 25°C	Q1		-4.0		
$R_{DS(on)}$	Static Drain-Source	$V_{GS} = 10 \text{ V}, I_{D} = 7.9 \text{ A}$	Q2		17	20	mΩ
	On-Resistance	$V_{GS} = 10 \text{ V}, I_D = 7.9 \text{ A}, T_J = 125^{\circ}\text{C}$			25 22	32 28	
		$V_{GS} = 4.5 \text{ V}, I_D = 7 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}$	Q1		21	29	
		$V_{GS} = 10 \text{ V}, I_D = 0.5 \text{ A}$ $V_{GS} = 10 \text{ V}, I_D = 6.5 \text{ A}, T_J = 125^{\circ}\text{C}$	Qı		32	49	
		$V_{GS} = 4.5 \text{ V}, I_D = 5.6 \text{ A}$			32	38	
$I_{D(on)}$	On-State Drain Current	V _{GS} = 10 V, V _{DS} = 5 V	Q2 Q1	30 20			Α
g _{FS}	Forward Transconductance	$V_{DS} = 5 \text{ V}, I_{D} = 7.9 \text{ A}$	Q2		25		S
		$V_{DS} = 5 \text{ V}, I_{D} = 6.5 \text{ A}$	Q1		15		
Dynami	c Characteristics						
C_{iss}	Input Capacitance	.,	Q2		550		pF
<u></u>	Output Conscitones	$V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V},$	Q1		720		~F
Coss	Output Capacitance	f = 1.0 MHz	Q2 Q1		180 120		pF
C _{rss}	Reverse Transfer Capacitance	1 = 1.0 WH IZ	Q2		70		pF
0155	reverse transfer supusidance		Q1		60		μ.
R_G	Gate Resistance	V _{GS} = 15mV, f = 1.0 MHz	Q2		3.2		Ω
			Q1		1.2		
Switchii	ng Characteristics (Note 2	0					
t _{d(on)}	Turn-On Delay Time		Q2		9	18	ns
	-		Q1		10	19	
t_r	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, I_D = 1 \text{ A},$	Q2		6	12	ns
4	Turn Off Dolov Time	V -10V B -60	Q1		4	8	
$\tau_{d(off)}$	Turn-Off Delay Time	$V_{GS} = 10V$, $R_{GEN} = 6 \Omega$	Q2 Q1		25 24	40 39	ns
t _f	Turn-Off Fall Time	1	Q2		4	8	ns
			Q1		3	6	
$t_{\text{d(on)}}$	Turn-On Delay Time		Q2 Q1		11 10	20 20	ns
t _r	Turn-On Rise Time	$V_{DD} = 15 \text{ V}, I_D = 1 \text{ A},$	Q2 Q1		15 9	26 18	ns
t _{d(off)}	Turn-Off Delay Time	$V_{GS} = 4.5V, R_{GEN} = 6 \Omega$	Q2		15	26	ns
-u(UII)	C 20, T	, 52	Q1		13	23	
t _f	Turn-Off Fall Time]	Q2		6	12	ns
			Q1		3	6	

Electrical Characteristics (continued)

T_A = 25°C unless otherwise noted

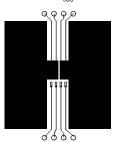
Symbol	Parameter	Test Conditions	Туре	Min	Тур	Max	Units
Switchi	ng Characteristics (Note 2)					
$Q_{g(TOT)}$	Total Gate Charge, Vgs = 10V		Q2 Q1		10 12	14 17	nC
Q_g	Total Gate Charge, Vgs = 5V	Q2: $V_{DS} = 15 \text{ V}, I_{D} = 7.9 \text{ A}$	Q2 Q1		5.6 6.5	8 9	nC
Q_{gs}	Gate-Source Charge	Q1: V _{DS} = 15 V, I _D = 6.5 A	Q2 Q1		2.0 2.3		nC
Q_{gd}	Gate-Drain Charge	$v_{DS} = 13 \text{ v}, I_D = 6.3 \text{ A}$	Q2 Q1		1.5 2.1		nC

Drain-Source Diode Characteristics and Maximum Ratings

I_S	Maximum Continuous Drain-Source Diode Forward Current		Q2		3.0	Α	
				Q1		1.3	
T_{rr}	Reverse Recovery Time	$I_F = 10 A,$		Q2	15		ns
Qrr	Reverse Recovery Charge	$d_{iF}/d_t = 300 \text{ A/}\mu\text{s}$	(Note 3)		6		nC
Trr	Reverse Recovery Time	$I_F = 6.5 A,$		Q1	20		ns
Qrr	Reverse Recovery Charge	$d_{iF}/d_t = 100 \text{ A/}\mu\text{s}$	(Note 3)		12		nC
V_{SD}	Drain-Source Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = 2.3 \text{ A}$ $V_{GS} = 0 \text{ V}, I_{S} = 1.3 \text{ A}$	(Note 2) (Note 2)	Q2 Q1	0.6 0.8	0.7 1.2	V

Notes

1. R_{0,0,4} is the sum of the junction-to-case and case-to-ambient thermal resistance where the case thermal reference is defined as the solder mounting surface of the drain pins. R_{0,0,0} is guaranteed by design while R_{0,0,4} is determined by the user's board design.



a) 78°C/W when mounted on a 0.5in² pad of 2 oz copper



125°C/W when mounted on a 0.02 in² pad of 2 oz copper 9999

c) 135°C/W when mounted on a minimum pad.

Scale 1:1 on letter size paper

- **2.** Pulse Test: Pulse Width < 300μ s, Duty Cycle < 2.0%
- 3. See "SyncFET Schottky body diode characteristics" below.
- 4. FDS6986AS-NL is a lead free product. FDS6986AS-NL marking will appear on the reel label.

Typical Characteristics: Q2

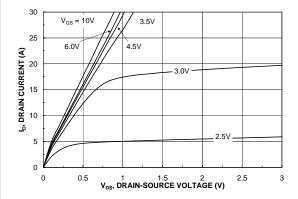


Figure 1. On-Region Characteristics.

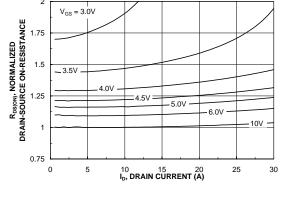


Figure 2. On-Resistance Variation with Drain Current and Gate Voltage.

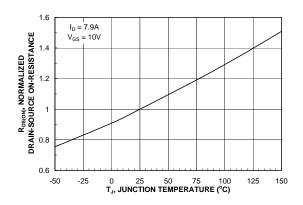


Figure 3. On-Resistance Variation with Temperature.

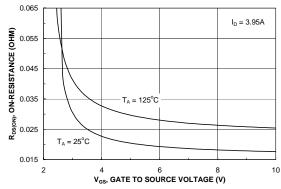


Figure 4. On-Resistance Variation with Gate-to-Source Voltage.

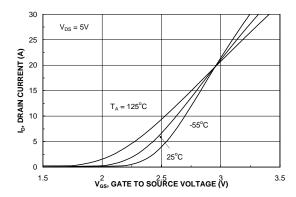


Figure 5. Transfer Characteristics.

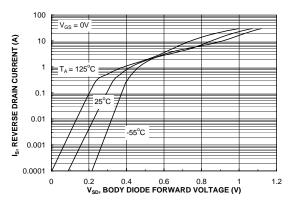


Figure 6. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics: Q2

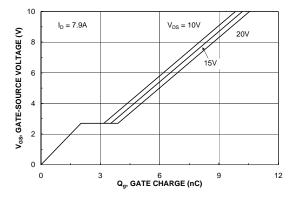
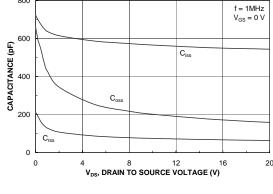


Figure 7. Gate Charge Characteristics.



800

Figure 8. Capacitance Characteristics.

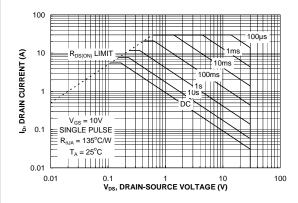


Figure 9. Maximum Safe Operating Area.

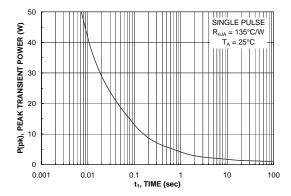


Figure 10. Single Pulse Maximum Power Dissipation.

Typical Characteristics Q1

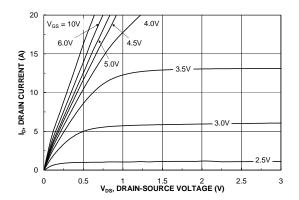


Figure 11. On-Region Characteristics.

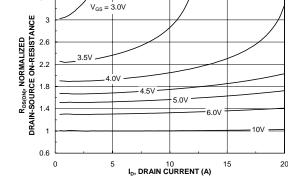


Figure 12. On-Resistance Variation with Drain Current and Gate Voltage.

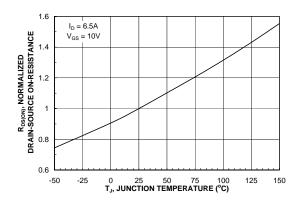


Figure 13. On-Resistance Variation with Temperature.

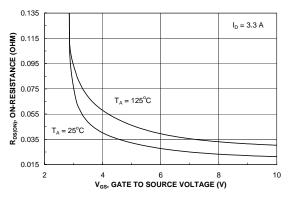


Figure 14. On-Resistance Variation with Gate-to-Source Voltage.

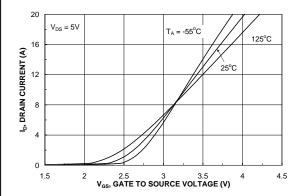


Figure 15. Transfer Characteristics.

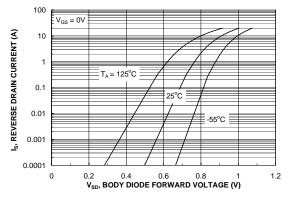
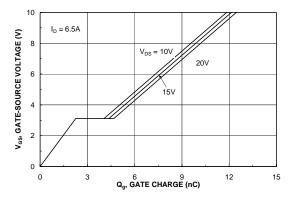


Figure 16. Body Diode Forward Voltage Variation with Source Current and Temperature.

Typical Characteristics Q1



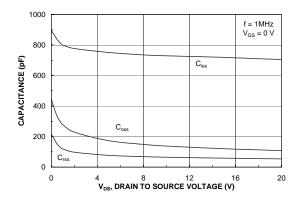
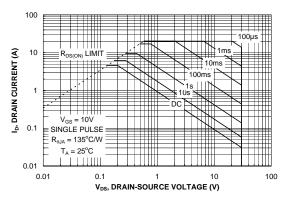


Figure 17. Gate Charge Characteristics.





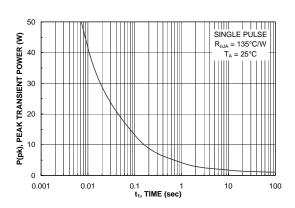


Figure 19. Maximum Safe Operating Area.

Figure 20. Single Pulse Maximum Power Dissipation.

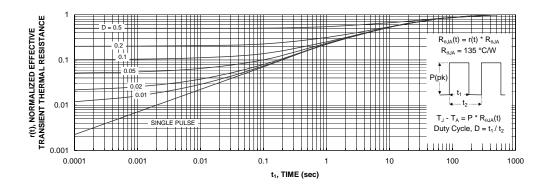


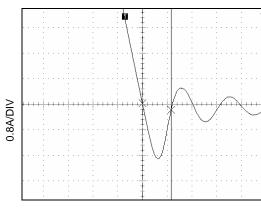
Figure 21. Transient Thermal Response Curve.

Thermal characterization performed using the conditions described in Note 1c. Transient thermal response will change depending on the circuit board design.

Typical Characteristics (continued)

SyncFET Schottky Body Diode Characteristics

ON Semiconductor's SyncFET process embeds a Schottky diode in parallel with PowerTrench MOSFET. This diode exhibits similar characteristics to a discrete external Schottky diode in parallel with a MOSFET. Figure 22 shows the reverse recovery characteristic of the FDS6986AS.



12.5nS/DIV

Figure 22. FDS6986AS SyncFET body diode reverse recovery characteristic.

For comparison purposes, Figure 23 shows the reverse recovery characteristics of the body diode of an equivalent size MOSFET produced without SyncFET (FDS6690A).

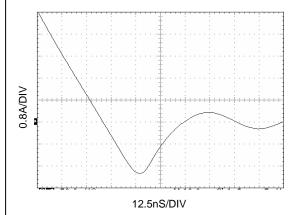


Figure 23. Non-SyncFET (FDS6690A) body diode reverse recovery characteristic.

Schottky barrier diodes exhibit significant leakage at high temperature and high reverse voltage. This will increase the power in the device.

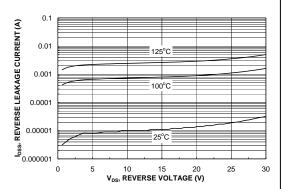
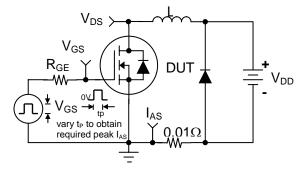


Figure 24. SyncFET body diode reverse leakage versus drain-source voltage and temperature.

Typical Characteristics



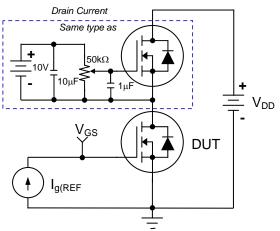
BV_{DSS}

V_{DS}

V_{DD}

Figure 25. Unclamped Inductive Load Test Circuit

Figure 26. Unclamped Inductive Waveforms



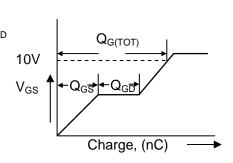
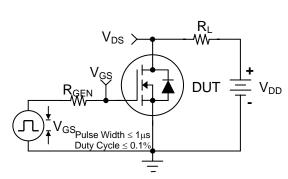


Figure 27. Gate Charge Test Circuit

Figure 28. Gate Charge Waveform



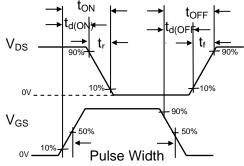


Figure 29. Switching Time Test Circuit

Figure 30. Switching Time Waveforms

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